


<b>Search Notes</b> 	<b>Application/Control No.</b> 10511419	<b>Applicant(s)/Patent Under Reexamination</b> MUELLER ET AL.
	<b>Examiner</b> Dinh Q Nguyen	<b>Art Unit</b> 3752

SEARCHED			
Class	Subclass	Date	Examiner
	updated search	3/2/8	DN

SEARCH NOTES		
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INTERFERENCE SEARCH			
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